New Jersey Semi-Conductor Products, Inc.

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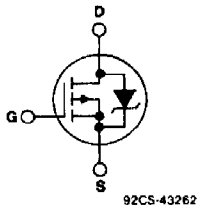
IRFF9230, IRFF9231, IRFF9232, IRFF9233

Avalanche-Energy-Rated P-Channel Power MOSFETs

-3.5 A and -4.0 A, -150 V and -200 V
$r_{DS}(on)$ = 0.8 Ω and 1.2 Ω

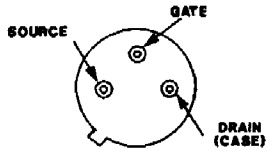
Features:
- *Single pulse avalanche energy rated*
- *SOA is power-dissipation limited*
- *Nanosecond switching speeds*
- *Linear transfer characteristics*
- *High input impedance*

TERMINAL DIAGRAM



P-CHANNEL ENHANCEMENT MODE

TERMINAL DESIGNATION



JEDEC TO-205AF

The IRFF9230, IRFF9231, IRFF9232 and IRFF9233 are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. These are p-channel enhancement-mode silicon gate power field-effect transistors designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high-power bipolar switching transistors requiring high speed and low gate-drive power. These types can be operated directly from integrated circuits.

The IRFF-types are supplied in the JEDEC TO-205AF (Low-Profile TO-39) metal package.

ABSOLUTE-MAXIMUM RATINGS

CHARACTERISTIC		IRFF9230	IRFF9231	IRFF9232	IRFF9233	UNITS
Drain-Source Voltage ①	V_{DS}	-200	-150	-200	-150	V
Drain-Gate Voltage (R_{GS} = 20 kΩ) ①	V_{DGR}	-200	-150	-200	-150	V
Continuous Drain Current	I_D @ T_C = 25°C	-4.0	-4.0	-3.5	-3.5	A
Pulsed Drain Current ③	I_{DM}	-16	-16	-14	-14	A
Gate-Source Voltage	V_{GS}	±20				V
Maximum Power Dissipation	P_D @ T_C = 25°C	25 (See Fig. 14)				W
Linear Derating Factor		0.2 (See Fig. 14)				W/°C
Single-Pulse Avalanche Energy Rating ④	E_{AS}	500				mj
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to +150				°C
Lead Temperature		300 (0.063 in. (1.6 mm) from case for 10s)				°C

Quality Semi-Conductors

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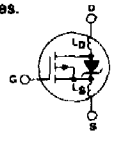
ELECTRICAL CHARACTERISTICS, At T_C = 25°C (Unless Otherwise Specified)

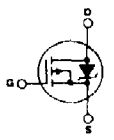
CHARACTERISTIC		TYPE	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
Drain-Source Breakdown Voltage	BV_{DSS}	IRFF9230 IRFF9232	-200	—	—	V	V_{GS} = 0 V
		IRFF9231 IRFF9233	-150	—	—	V	I_D = -250 μA
Gate Threshold Voltage	$V_{GS}(th)$	ALL	-2.0	—	-4.0	V	V_{DS} = V_{GS}, I_D = -250 μA
Gate-Source Leakage Forward	I_{GSS}	ALL	—	—	-100	nA	V_{GS} = -20 V
Gate-Source Leakage Reverse	I_{GSS}	ALL	—	—	100	nA	V_{GS} = 20 V
Zero-Gate Voltage Drain Current	I_{DSS}	ALL	—	—	-250	μA	V_{DS} = Max. Rating, V_{GS} = 0 V
			—	—	-1000	μA	V_{DS} = Max. Rating x 0.8, V_{GS} = 0 V, T_C = 125°C
On-State Drain Current ②	$I_D(on)$	IRFF9230 IRFF9231	-4.0	—	—	A	$V_{DS} > I_D(on) \times r_{DS}(on)$ max., V_{GS} = -10 V
		IRFF9232 IRFF9233	-3.5	—	—	A	
Static Drain-Source On-State Resistance ②	$r_{DS}(on)$	IRFF9230 IRFF9231	—	0.5	0.8	Ω	V_{GS} = -10 V, I_D = -2.0 A
		IRFF9232 IRFF9233	—	0.8	1.2	Ω	
Forward Transconductance ②	g_{fs}	ALL	2.2	3.5	—	S (℧)	$V_{DS} > I_D(on) \times r_{DS}(on)$ max., I_D = 2.0 A
Input Capacitance	C_{iss}	ALL	—	550	—	pF	V_{GS} = 0 V, V_{DS} = -25 V, f = 1.0 MHz See Fig. 10
Output Capacitance	C_{oss}	ALL	—	170	—	pF	
Reverse Transfer Capacitance	C_{rss}	ALL	—	50	—	pF	
Turn-On Delay Time	$t_d(on)$	ALL	—	30	50	ns	V_{DD} = 0.5 BV_{DSS}, I_D = 2.0 A, Z_O = 50 Ω See Fig. 17 (MOSFET switching times are essentially independent of operating temperature.)
Rise Time	t_r	ALL	—	50	100	ns	
Turn-Off Delay Time	$t_d(off)$	ALL	—	50	100	ns	
Fall Time	t_f	ALL	—	40	80	ns	
Total Gate Charge (Gate-Source Plus Gate-Drain)	Q_g	ALL	—	31	45	nC	V_{GS} = -15 V, I_D = -8.0 A, V_{DS} = 0.8 Max. Rating. See Fig. 18 for test circuit. (Gate charge is essentially independent of operating temperature.)
Gate-Source Charge	Q_{gs}	ALL	—	18	26	nC	
Gate-Drain ("Miller") Charge	Q_{gd}	ALL	—	13	19	nC	
Internal Drain Inductance	L_D	ALL	—	5.0	—	nH	Measured from the drain lead, 5mm (0.2 in.) from header to center of die.
Internal Source Inductance	L_S	ALL	—	15.0	—	nH	Measured from the source lead, 5mm (0.2 in.) from header to source bonding pad.
Junction-to-Case	$R_{\theta JC}$	ALL	—	—	5.0	°C/W	
Junction-to-Ambient	$R_{\theta JA}$	ALL	—	—	175	°C/W	Typical socket mount.

Modified MOSFET symbol showing the internal device inductances.



SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Continuous Source Current (Body Diode)	I_S	IRFF9230 IRFF9231	—	—	-4.0	A	Modified MOSFET symbol showing the integral reverse P-N junction rectifier.
		IRFF9232 IRFF9233	—	—	-3.5	A	
Pulse Source Current (Body Diode) ③	I_{SM}	IRFF9230 IRFF9231	—	—	-16	A	
		IRFF9232 IRFF9233	—	—	-14	A	
Diode Forward Voltage ②	V_{SD}	IRFF9230 IRFF9231	—	—	-1.5	V	T_C = 25°C, I_S = -4.0 A, V_{GS} = 0 V
		IRFF9232 IRFF9233	—	—	-1.5	V	T_C = 25°C, I_S = -3.5 A, V_{GS} = 0 V
Reverse Recovery Time	t_{rr}	ALL	—	400	—	ns	T_J = 150°C, I_F = -4.0 A, di_F/dt = 100 A/μs
Reverse Recovered Charge	Q_{RR}	ALL	—	2.6	—	μC	T_J = 150°C, I_F = -4.0 A, di_F/dt = 100 A/μs
Forward Turn-on Time	t_{on}	ALL	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L_S + L_D.				



① T_J = 25°C to 150°C.

② Pulse Test: Pulse width ≤ 300 μs. Duty Cycle ≤ 2%

③ Repetitive Rating: Pulse width limited by max. junction temperature See Transient Thermal Impedance Curve (Fig. 5).

④ V_{DD} = 50 V, Starting T_J = 25°C, L = 46.9 mH, R_G = 25 Ω, Peak I_L = 4.0 A (See Figs. 15 & 16).